

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10605944	BOUDON ET AL.
	Examiner	Art Unit
	Wai, Eric C	2195

SEARCHED

Class	Subclass	Date	Examiner
718	100	07/09/2007	ECW
365	221	12/14/2007	ECW
711	144	6/4/2008	ECW
370	545	6/4/2008	ECW
326	38	12/3/2008	ECW

SEARCH NOTES

Search Notes	Date	Examiner
Inventor's Name Search	07/09/2007	ECW
East Search	07/09/2007	ECW
Updated East Search	12/14/2007	ECW
Google Scholar Search	12/14/2007	ECW
Updated East Search	6/4/2008	ECW
Updated East Search	12/03/2008	ECW

INTERFERENCE SEARCH

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